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Search

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Try our New Full-text Search Prototype **GO**[Help](#)

- 1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
- 2) Limit your search by using search operators and field codes, if desired.
Example: optical <and> (fiber <or> fibre) <in> ti
- 3) Limit the results by selecting Search Options.
- 4) Click Search. See [Search Examples](#)

(e or electron) and (beam or ray or array or irradiat*)
and (pore or porous or void)
and (dielectric)

Start Search**Clear**

Note: This function returns plural and suffixed forms of the keyword(s).

Search operators: <and> <or> <not> <in> [More](#)

Field codes: au (author), ti (title), ab (abstract), jn (publication name), de (index term) [More](#)

Search Options:**Select publication types:**

- ☒ IEEE Journals
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- ☒ IEEE Standards

Select years to search:

From year: **All** to **Present**

Organize search results by:

Sort by: **Relevance**

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List **15** Results per page